

Notice of References Cited

Application/Control No.

10/583,363

Applicant(s)/Patent Under
Reexamination
EARNSHAW, JOHN MICHAEL

Examiner

Winnie Yip

Art Unit

3636

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-281,675 A	07-1883	Eichling & Fitch	248/278.1
*	B	US-508,418 A	11-1893	Heaney	248/514
*	C	US-565,619 A	08-1896	Heaney	135/21
*	D	US-0970751	09-1910	Pranke	248/515
*	E	US-2,605,778 A	08-1952	CLAPPER CLYDE E	135/20.1
*	F	US-2,767,723 A	10-1956	SEARS JR ISAAC WEIR	135/21
*	G	US-3,765,434 A	10-1973	Riggs, Royal W.	135/20.1
*	H	US-5,002,081 A	03-1991	Stromeyer, Markus	135/21
*	I	US-5,116,258 A	05-1992	Vennik, Johan	135/20.3
*	J	US-5,499,644 A	03-1996	Geniele, Henry	135/20.1
*	K	US-5,937,881 A	08-1999	Villa, Mike	135/20.1
*	L	US-6,629,727 B2	10-2003	Asbach et al.	297/188.21
*	M	US-7,461,665 B2	12-2008	Koehn, Ekkehard	135/21

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.